



P/1805-17

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

Markus TURTINEN

Serial No.: 10/526,831

Filed: July 20, 2005

New York, New York

Date: November 4, 2005

Group Art Unit: 2856

Examiner: ---

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Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUBMISSION

Sir:

Submitted herewith is a copy of a search report issued by a patent searching authority other than the PTO and the cited art together with a form listing the same for the convenience of the Examiner.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents P.O. Box 1450, Alexandria, VA 22313-1450, on November 4, 2005

Robert C. Faber

Name of applicant, assignee or Registered Representative

Signature / November 4, 2005

Date of Signature

Respectfully submitted,

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RCF:mjb Enclosures

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